Notice of References Cited

Application/Control No. 09/877,820	Applicant(s)/Patent Under Reexamination JAIN ET AL.		
Examiner	Art Unit		
Andrew C. Lee	2616	Page 1 of 1	

.U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,909,905	06-2005	Umeda et al.	455/522
*	В	US-6,128,506	10-2000	Knutsson et al.	455/522
*	С	US-7,085,581	08-2006	Vanghi, Vieri	455/522
*	D	US-5,974,106	10-1999	Dupont et al.	375/377
*	E	US-6,707,862	03-2004	Larsson, Torbjorn	375/326
*	F	US-2003/0054773	03-2003	Vanghi, Vieri	455/70
*	G	US-6,549,785	04-2003	Agin, Pascal	455/522
*	Н	US-6,718,171	04-2004	Hunzinger, Jason F.	455/450
*	-	US-5,621,723	04-1997	Walton et al.	370/335
*	J	US-6,553,235	04-2003	Bark et al.	455/453
*	К	US-6,668,159	12-2003	Olofsson et al.	455/67.11
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	s				,	
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	٧	
	w	
	x	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.